



POWER-MOS FET

FIELD EFFECT POWER TRANSISTOR

**IRF350,351
D86FQ2,Q1**

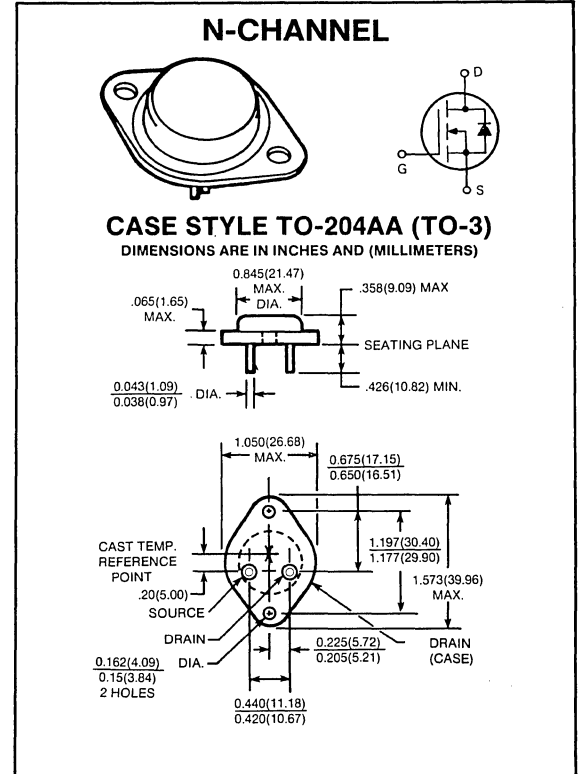
**15 AMPERES
400, 350 VOLTS
R_{DS(ON)} = 0.3 Ω**

This series of N-Channel Enhancement-mode Power MOSFETs utilizes GE's advanced Power DMOS technology to achieve low on-resistance with excellent device ruggedness and reliability.

This design has been optimized to give superior performance in most switching applications including: switching power supplies, inverters, converters and solenoid/relay drivers. Also, the extended safe operating area with good linear transfer characteristics makes it well suited for many linear applications such as audio amplifiers and servo motors.

Features

- Polysilicon gate — Improved stability and reliability
- No secondary breakdown — Excellent ruggedness
- Ultra-fast switching — Independent of temperature
- Voltage controlled — High transconductance
- Low input capacitance — Reduced drive requirement
- Excellent thermal stability — Ease of paralleling



maximum ratings ($T_C = 25^\circ\text{C}$) (unless otherwise specified)

| RATING | SYMBOL | IRF350/D86FQ2 | IRF351/D86FQ1 | UNITS |
|---|----------------|---------------|---------------|------------------------------|
| Drain-Source Voltage | V_{DSS} | 400 | 350 | Volts |
| Drain-Gate Voltage, $R_{GS} = 1M\Omega$ | V_{DGR} | 400 | 350 | Volts |
| Continuous Drain Current @ $T_C = 25^\circ\text{C}$ @ $T_C = 100^\circ\text{C}$ | I_D | 15 9 | 15 9 | A A |
| Pulsed Drain Current ⁽¹⁾ | I_{DM} | 60 | 60 | A |
| Gate-Source Voltage | V_{GS} | ± 20 | ± 20 | Volts |
| Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate Above 25°C | P_D | 150 1.2 | 150 1.2 | Watts W/ $^\circ\text{C}$ |
| Operating and Storage Junction Temperature Range | T_J, T_{STG} | -55 to 150 | -55 to 150 | $^\circ\text{C}$ |

thermal characteristics

| | | | | |
|---|-----------------|------|------|--------------------|
| Thermal Resistance, Junction to Case | $R_{\theta JC}$ | 0.83 | 0.83 | $^\circ\text{C/W}$ |
| Thermal Resistance, Junction to Ambient | $R_{\theta JA}$ | 30 | 30 | $^\circ\text{C/W}$ |
| Maximum Lead Temperature for Soldering Purposes: $\frac{1}{8}$ " from Case for 5 Seconds | T_L | 260 | 260 | $^\circ\text{C}$ |

(1) Repetitive Rating: Pulse width limited by max. junction temperature.

electrical characteristics ($T_C = 25^\circ\text{C}$) (unless otherwise specified)

| CHARACTERISTIC | SYMBOL | MIN | TYP | MAX | UNIT |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

off characteristics

| | | | | | | |
|--|--------------------------------|------------|------------|--------|-------------|---------|
| Drain-Source Breakdown Voltage ($V_{GS} = 0V, I_D = 250 \mu A$) | IRF350/D86FQ2 IRF351/D86FQ1 | BV_{DSS} | 400 350 | — — | — — | Volts |
| Zero Gate Voltage Drain Current ($V_{DS} = \text{Max Rating}, V_{GS} = 0V, T_C = 25^\circ\text{C}$) ($V_{DS} = \text{Max Rating}, \times 0.8, V_{GS} = 0V, T_C = 125^\circ\text{C}$) | | I_{DSS} | — — | — — | 250 1000 | μA |
| Gate-Source Leakage Current ($V_{GS} = \pm 20V$) | | I_{GSS} | — | — | ± 100 | nA |

on characteristics*

| | | | | | | |
|---|--------------------------|--------------|-----|------|------|-------|
| Gate Threshold Voltage ($V_{DS} = V_{GS}, I_D = 250 \mu A$) | $T_C = 25^\circ\text{C}$ | $V_{GS(TH)}$ | 2.0 | — | 4.0 | Volts |
| On-State Drain Current ($V_{GS} = 10V, V_{DS} = 10V$) | | $I_{D(ON)}$ | 15 | — | — | A |
| Static Drain-Source On-State Resistance ($V_{GS} = 10V, I_D = 8A$) | | $R_{DS(ON)}$ | — | 0.26 | 0.30 | Ohms |
| Forward Transconductance ($V_{DS} = 10V, I_D = 8A$) | | g_{fs} | 5.6 | 8.0 | — | mhos |

dynamic characteristics

| | | | | | | |
|------------------------------|---------------------|-----------|---|------|------|----|
| Input Capacitance | $V_{GS} = 0V$ | C_{iss} | — | 2800 | 3000 | pF |
| Output Capacitance | $V_{DS} = 25V$ | C_{oss} | — | 300 | 600 | pF |
| Reverse Transfer Capacitance | $f = 1 \text{ MHz}$ | C_{rss} | — | 60 | 200 | pF |

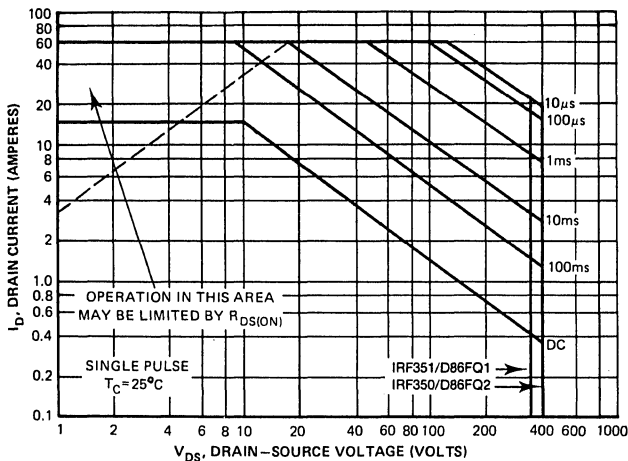
switching characteristics*

| | | | | | | |
|---------------------|---|--------------|---|-----|---|----|
| Turn-on Delay Time | $V_{DS} = 175V$ | $t_{d(on)}$ | — | 20 | — | ns |
| Rise Time | $I_D = 8A, V_{GS} = 15V$ | t_r | — | 25 | — | ns |
| Turn-off Delay Time | $R_{GEN} = 50\Omega, R_{GS} = 12.5\Omega$ | $t_{d(off)}$ | — | 110 | — | ns |
| Fall Time | $(R_{GS} \text{ (EQUIV.)} = 10\Omega)$ | t_f | — | 70 | — | ns |

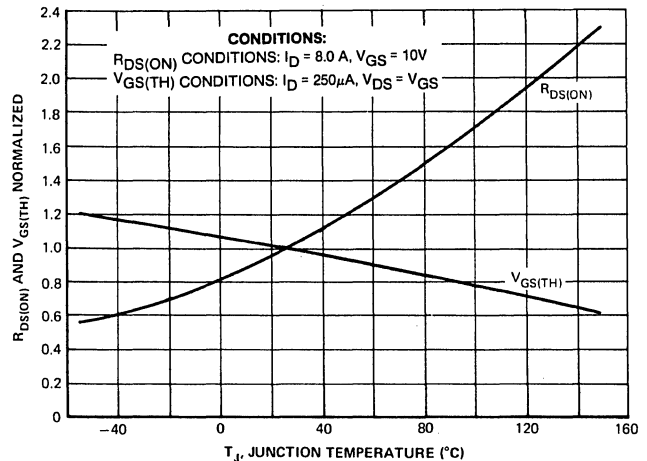
source-drain diode ratings and characteristics*

| | | | | | | |
|---|--|----------------------|---|------------|-----|---------------|
| Continuous Source Current | | I_S | — | — | 15 | A |
| Pulsed Source Current | | I_{SM} | — | — | 60 | A |
| Diode Forward Voltage ($T_C = 25^\circ\text{C}, V_{GS} = 0V, I_S = 15A$) | | V_{SD} | — | 1.0 | 1.6 | Volts |
| Reverse Recovery Time ($I_S = 15A, di_S/dt = 100A/\mu\text{sec}, T_C = 125^\circ\text{C}$) | | t_{rr} Q_{RR} | — | 500 6.5 | — | ns μC |

*Pulse Test: Pulse width $\leq 300 \mu s$, duty cycle $\leq 2\%$



MAXIMUM SAFE OPERATING AREA



TYPICAL NORMALIZED $R_{DS(ON)}$ AND $V_{GS(TH)}$ VS. TEMP.